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DEC 21 2004 U.S. PATENT AND TRADEMARK OFFICE (37 CFR §1.98(b))		Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Wolfgang Kalthoff et al.	
				Filing Date December 30, 2003	Group Art Unit 2133

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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			8-7-06
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			